## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No
nfirmation No
Filing Date June 19, 2001
Inventor Richard Holscher et al.
Assignee Micron Technology, Inc.
Group Art Unit
Examiner Unknown
Attorney's Docket No
Customer No
Title: Semiconductor Processing Methods

## **INFORMATION DISCLOSURE STATEMENT**

References -- See Attached Form PTO-1449

The attached Form PTO-1449 is submitted in compliance with 37 CFR §1.56. No admission is made regarding whether the submitted references are prior art.

This Information Disclosure Statement is being filed within three months of the filing of the application or before the mailing of a first Office Action on the merits, whichever occurs last. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Information Disclosure Statement, please charge the fee specified under 37 C.F.R. Section 1.17(p) to Deposit Account No. 23-0925. Please credit Deposit Account No. 23-0925 with any overpayment of the above fee.

Respectfully submitted,

ated: \_\_///3/64\_\_\_\_ Attorney:

Robert C. Hyta Reg. No. 46,791

EL979978767

Form PTO-14	<u> </u>	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE					ATTY. DOCKET NO. MI22-1694			SERIAL NO. 09/885,393		
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TRADE	MARHA	, –			U.S. PATENT DOCUMENTS							
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EXAMINER			<u> </u>			DATE CONSIDER	ED		· -			
SCYAMINED. Initial if reference considered whether or not citation is in conformance with MDED 600. Draw line through citation if not in conformance and reference												
Include copy of	*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.											

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ATTY. DOCKET NO. MI22-1694 SERIAL NO. 09/885,393

LIST OF ART CITED BY APPLICANT

APPLICANT Richard Holscher et al.

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